

Form PTO-1449 U.S. Department of Commerce
(REV. 2-82) Patent and Trademark Office

Atty. Docket No.
036179/US/2-475387-30

Serial No.
10/577,562

**INFORMATION DISCLOSURE STATEMENT
BY APPLICANT**
(Use several sheets if necessary)

Applicant(s)
Seok-Hyun Yun et al.

Filing Date
April 27, 2006

Confirmation No.
3634

U.S. PATENT DOCUMENTS

*Exam. Init.	Document No.	Date	Name	Class	Subclass	Filing Date if Appropriate
	6 0 2 0 9 6 3	February 1, 2000	Dimarzio et al. ΩΩΩΩΩ			
	6 3 4 1 0 3 6	January 22, 2002	Tearney et al. ΩΩΩΩΩ			
	6 3 9 6 9 4 1	May 28, 2002	Bacus, James W. et al. ΩΩΩΩΩΩΩ			
200	5 0 1 8 2 0 1	January 27, 2005	De Boer, Johannes F. Et al ΩΩΩΩΩΩΩ			
	6 5 6 7 5 8 5	May 20, 2003	Martin et al. ΩΩΩΩΩΩΩΩ			
	5 9 2 6 5 9 2	July 20, 1999	Martin et al. ΩΩΩΩΩΩΩΩ			
	7 2 6 7 4 9 4	September 11, 2007	Hongyu et al. ΩΩΩΩΩΩΩΩ			
	5 9 7 5 6 9 7	November 2, 1999	Podoleanu et al.			
	5 2 4 1 3 6 4	August 31, 1993	Kimura et al. ΩΩΩΩΩΩΩΩΩ Ω			
	5 9 1 0 8 3 9	June 8, 1999	Erschine et al. ΩΩΩΩΩΩΩΩΩ Ω			
200	7 0 7 0 4 9 6	March 29, 2007	Gweon et al. ΩΩΩΩΩΩΩΩΩ Ω			
	4 8 2 7 9 0 7	May 9, 1989	Tashiro et al. ΩΩΩΩΩΩΩΩΩ ΩΩ			
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	5 7 3 0 7 3 1	March 24, 1998	Mollenauer et al. ΩΩΩΩΩΩΩΩΩ ΩΩ			

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	200	3	1	2	0	1	3	7	June 26, 2003	Pawluczyk et al. YYY			
	200	2	0	9	1	3	2	2	July 11, 2002	Chaiken et al. YY			
	2005	0	1	6	5	3	0	3	July 28, 2005	Kleen Martin et al. YYY			
	200	2	0	5	2	5	4	7	May 2, 2002	Toida Masahiro YY			
	200	4	0	0	2	6	5	0	January 1, 2004	Mandrusov Evgenia et al. YYY			
	200	3	0	8	2	1	0	5	May 1, 2003	Fischman, Alan et al. YYY			
		5	3	0	4	1	7	3	April 19, 1994	Kittrell, Carter et al. YYY			
		7	3	3	6	3	6	6	February 26, 2008	Choma et al.			
		7	0	1	9	8	3	8	March 28, 2006	Izatt et al.			
		6	3	7	4	1	2	8	April 16, 2002	Toida et al.			
		6	4	7	7	4	0	3	November 5, 2002	Eguchi et al.			
		5	5	5	5	0	8	7	September 10, 1996	Miyagawa et al. YYYYI			
	200	5	0	5	7	7	5	6	March 17, 2005	Fang-Yen et al. YYYY			
		4	5	8	5	3	4	9	April 29, 1986	Gross Daniel et al.			
		5	7	8	5	6	5	1	July 28, 1998	Baker et al. YYYYY			

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		5	8	1	7	1	4	4	October 6, 1998	Gregory Kenton et al. YYYYY			
	2003	0	1	7	4	3	3	9	September 18, 2003	Feldchtein et al.			
	200	3	0	3	0	8	1	6	February 13, 2003	Eom Tae Bong et al.			
	200	2	0	5	7	4	3	1	May 16, 2002	Fateley William G. et al			
	2005	0	0	5	7	6	8	0	March 2005	Agan, Martin J. YYYYYY			
		5	3	4	8	0	0	3	September 1994	Caro, Richard G. YYYYYY			
		5	2	5	0	1	8	6	October 1993	Dollinger et al. YYYYYY			
		5	3	9	4	2	3	5	February 1995	Takeuchi et al. YYYYYY			
		6	2	4	9	3	8	1	June 2001	Suganuma, Hiroshi YYYYYY			
		6	9	0	9	1	0	5	June 2005	Heintzmann et al. YYYYYYYY			
		7	2	3	6	6	3	7	June 2007	Sirohey et al. YYYYYYYY			
	2002	0	0	4	8	0	2	5	April 2002	Takaoka, Hideyuki €			
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		Document No.							Date	Country	Class	SubClass	Translator	
		7	9	0	0	8	4	1					Yes	No
		7	9	0	0	8	4	1	October 18, 1979	WIPO ΩΩ				
		9	8	0	0	0	5	7	January 8, 1998	WIPO ΩΩΩ				
200		2	0	8	4	2	6	3	October 24, 2002	WIPO ΩΩΩΩΩ				
200		4	0	5	7	2	6	6	July 8, 2004	WIPO ΩΩΩΩΩ				
200		1	0	2	7	6	7	9	April 19, 2001	WIPO ΩΩΩΩΩΩ				
200		3	0	4	6	6	3	6	June 5, 2003	WIPO ΩΩΩΩΩΩ				
200		6	0	0	4	7	4	3	January 12, 2006	WIPO ΩΩΩΩΩΩ ΩΩΩΩ				
		9	2	0	1	9	6	6	February 6, 1992	WIPO ¥				
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		5	5	0	9	4	1	7	November 22, 1993	Japan ¥				
		2	7	3	8	3	4	3	August 30, 1995	France ¥				
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		2	2	9	8	0	5	4	August 21, 1996	Great Britain ¥¥¥				
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		0	1	0	1	1	1	1	January 2001	WIPO €€				

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~~YYYYYY~~ Reference cited in Office Action dated August 18, 2009 for U.S. Patent application no. 12/277,178

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~~YYYYYYYY~~ Reference cited in Office Action dated August 6, 2009 for U.S. Patent application no. 11/624,455

~~YYYYYYYYY~~ Reference cited in Office Action dated May 15, 2009 for U.S. Patent application no. 11/537,123

€ Reference cited in Office Action dated April 17, 2009 for U.S. Patent application no. 11/537,343

€€ Reference cited in Office Action dated April 15, 2009 for U.S. Patent application no. 12/205,775

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		Copy of Notification Concerning Transmittal of Copy of International Preliminary Report on Patentability dated October 13, 2005 for PCT/US04/10152
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